

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/007,696	TESSMAN ET AL.
	<b>Examiner</b> Merilyn P. Nguyen	<b>Art Unit</b> 2163

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
707	104.1	3/30/2006	MN
707	200	3/30/2006	MN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated East Searched	3/30/2006	MN
NPL Searched (IEEE, ACM)	4/17/2006	MN
STIC Searched	11/14/2005	MN
Consulted with Luke Wassum (AU 2167)	3/30/2006	MN
Inventor Searched	4/17/2006	MN
101 Panel Help	3/31/2006	MN